

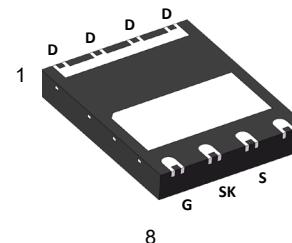
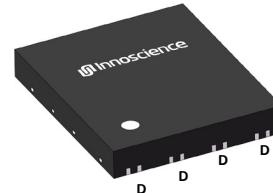
# INN650DA150A

## 1. General description

650V GaN-on-silicon Enhancement-mode Power Transistor in Dual Flat No-lead package (DFN) with 5 mm × 6 mm size

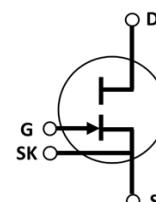
## 2. Features

- Enhancement mode transistor-Normally off power switch
- Ultra high switching frequency
- No reverse-recovery charge
- Low gate charge, low output charge
- Qualified for industrial applications according to JEDEC Standards
- ESD safeguard
- RoHS, Pb-free, REACH-compliant



## 3. Applications

- AC-DC converters
- DC-DC converters
- Totem pole PFC
- Fast battery charging
- High density power conversion
- High efficiency power conversion



## 4. Key performance parameters

Table 1 Key performance parameters at  $T_j = 25^\circ\text{C}$

Parameter	Value	Unit
$V_{DS,\text{max}}$	650	V
$R_{DS(\text{on}),\text{max}} @ V_{GS} = 6 \text{ V}$	150	$\text{m}\Omega$
$Q_{G,\text{typ}} @ V_{DS} = 400 \text{ V}$	3	$\text{nC}$
$I_{D,\text{pulse}}$	32	A
$Q_{oss} @ V_{DS} = 400 \text{ V}$	28	$\text{nC}$
$Q_{rr} @ V_{DS} = 400 \text{ V}$	0	$\text{nC}$

## 5. Pin information

Table 2 Pin information

Gate	Drain	Kelvin Source	Source
8	1,2,3,4	7	5,6

Table 3 Ordering information

Type/Ordering Code	Package	Marking (Product Code)
INN650DA150A	DFN 5X6	INN650DA150A

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## 6. Maximum ratings

at  $T_j = 25^\circ\text{C}$  unless otherwise specified.

Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact Innosience sales office.

**Table 4 Maximum ratings**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain source voltage	$V_{DS,\text{max}}$	-	-	650	V	$V_{GS} = 0 \text{ V}$ , $I_D = 25 \mu\text{A}$
Drain source voltage transient <sup>1</sup>	$V_{DS(\text{transient})}$	-	-	750	V	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 750 \text{ V}$
Continuous current, drain source	$I_D$	-	-	17	A	$T_c = 25^\circ\text{C}$
Pulsed current, drain source <sup>2</sup>	$I_{D,\text{pulse}}$	-	-	32	A	$T_c = 25^\circ\text{C}$ ; $V_G = 6 \text{ V}$ ; See Figure 16;
Pulsed current, drain source <sup>2</sup>	$I_{D,\text{pulse}}$	-	-	23	A	$T_c = 125^\circ\text{C}$ ; $V_G = 6 \text{ V}$ ; See Figure 17;
Gate source voltage, continuous <sup>3</sup>	$V_{GS}$	-1.4	-	+7	V	$T_j = -55^\circ\text{C}$ to $150^\circ\text{C}$
Gate source voltage, pulsed	$V_{GS,\text{pulse}}$	-20	-	+10	V	$T_j = -55^\circ\text{C}$ to $150^\circ\text{C}$ ; $t_{PULSE} = 50 \text{ ns}$ , $f = 100 \text{ kHz}$ open drain
Power dissipation	$P_{\text{tot}}$	-	-	113	W	$T_c = 25^\circ\text{C}$
Operating temperature	$T_j$	-55	-	+150	°C	
Storage temperature	$T_{stg}$	-55	-	+150	°C	

1  $V_{DS(\text{transient})}$  is intended for surge rating during non-repetitive events,  $t_{PULSE} < 1 \mu\text{s}$

2 Pulse = 300  $\mu\text{s}$

3 The minimum  $V_{GS}$  is clamped by ESD protection circuit, as shown in Figure 10

## 7. Thermal characteristics

Table 5 Thermal characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R <sub>thJC</sub>	-	-	1.1	°C/W	
Reflow soldering temperature	T <sub>sold</sub>	-	-	260	°C	MSL3

## 8. Electric characteristics

at  $T_j = 25^\circ\text{C}$ , unless specified otherwise

**Table 6 Static characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate threshold voltage	$V_{GS(th)}$	1.2	1.6	2.2	V	$I_D = 17.2 \text{ mA}; V_{DS} = V_{GS}; T_j = 25^\circ\text{C}$
		-	1.5	-		$I_D = 17.2 \text{ mA}; V_{DS} = V_{GS}; T_j = 125^\circ\text{C}$
Drain-source leakage current	$I_{DSS}$	-	0.7	25	$\mu\text{A}$	$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$
		-	6	200		$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150^\circ\text{C}$
Gate-source leakage current	$I_{GS}$	-	30	-	$\mu\text{A}$	$V_{GS} = 6 \text{ V}; V_{DS} = 0 \text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	115	150	$\text{m}\Omega$	$V_{GS} = 6 \text{ V}; I_D = 5 \text{ A}; T_j = 25^\circ\text{C}$
		-	234	-	$\text{m}\Omega$	$V_{GS} = 6 \text{ V}; I_D = 5 \text{ A}; T_j = 150^\circ\text{C}$
Gate resistance	$R_G$	-	1.4	-	$\Omega$	$f = 5 \text{ MHz}; \text{open drain}$

**Table 7 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$	-	110	-	$\text{pF}$	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Output capacitance	$C_{oss}$	-	30	-	$\text{pF}$	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Reverse transfer capacitance	$C_{rss}$	-	0.46	-	$\text{pF}$	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Effective output capacitance, energy related <sup>1</sup>	$C_{o(er)}$	-	42	-	$\text{pF}$	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Effective output capacitance, time related <sup>2</sup>	$C_{o(tr)}$	-	68	-	$\text{pF}$	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Output charge	$Q_{oss}$	-	28	-	$\text{nC}$	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Turn-on delay time	$t_{d(on)}$	-	3	-	$\text{nS}$	See Figure 22
Turn-off delay time	$t_{d(off)}$	-	7	-	$\text{nS}$	See Figure 22
Rise time	$t_r$	-	5	-	$\text{nS}$	See Figure 22
Fall time	$t_f$	-	5	-	$\text{nS}$	See Figure 22

1  $C_{o(er)}$  is the fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

2  $C_{o(tr)}$  is the fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

**Table 8 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate charge	Q <sub>G</sub>	-	3	-	nC	V <sub>GS</sub> = 0 to 6 V; V <sub>DS</sub> = 400 V; I <sub>D</sub> = 5 A
Gate-source charge	Q <sub>GS</sub>	-	0.28	-	nC	
Gate-drain charge	Q <sub>GD</sub>	-	1.63	-	nC	
Gate Plateau Voltage	V <sub>Plat</sub>	-	2.3	-	V	

**Table 9 Reverse conduction characteristics**

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Source-Drain reverse voltage	V <sub>SD</sub>	-	2.6	-	V	V <sub>GS</sub> = 0 V; I <sub>S</sub> = 5 A
Pulsed current, reverse	I <sub>S,pulse</sub>	-	-	32	A	V <sub>GS</sub> = 6 V
Reverse recovery charge	Q <sub>rr</sub>	-	0	-	nC	I <sub>SD</sub> = 5 A; V <sub>DS</sub> = 400 V
Reverse recovery time	t <sub>rr</sub>	-	0	-	ns	
Peak reverse recovery current	I <sub>rrm</sub>	-	0	-	A	

## 9. Electric characteristics diagrams

at  $T_j = 25^\circ\text{C}$ , unless specified otherwise

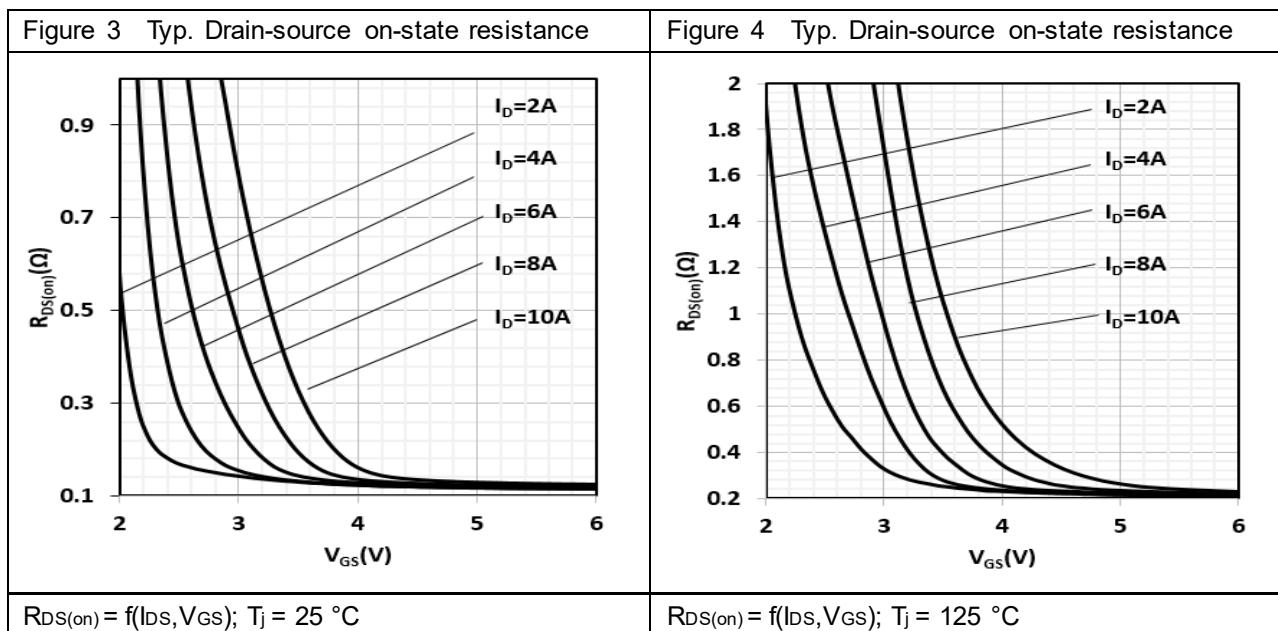
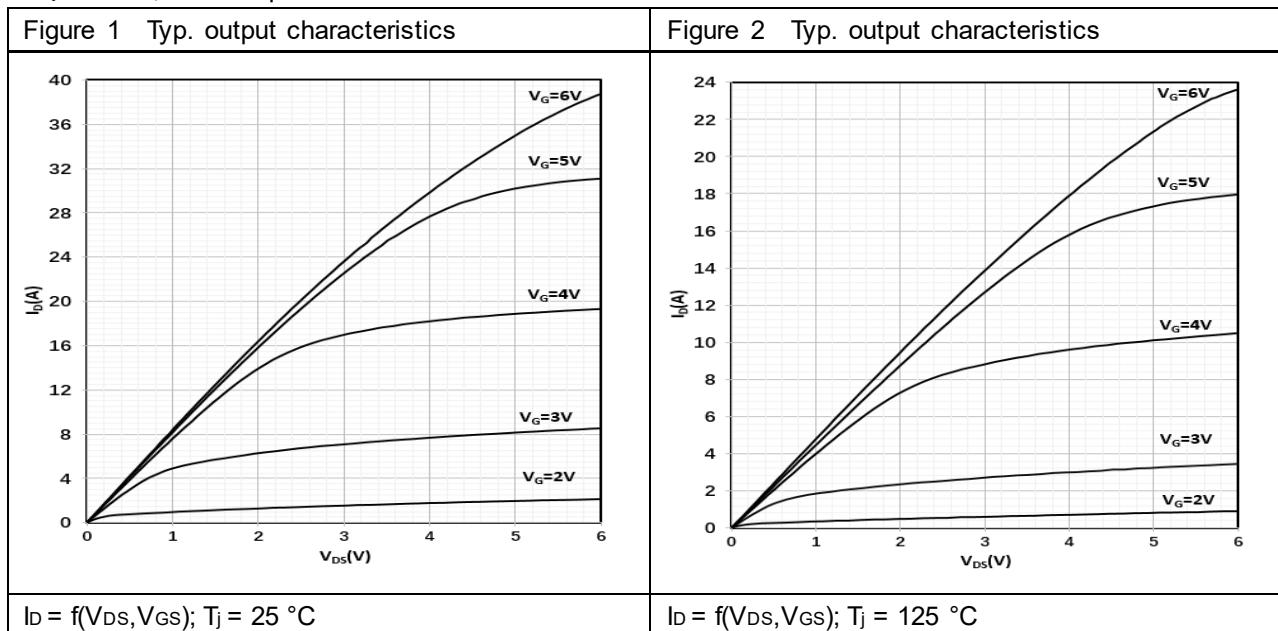


Figure 5 Typ. channel reverse characteristics

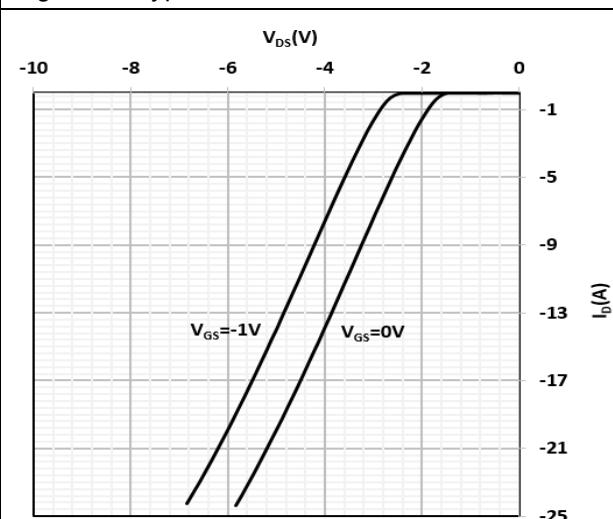
 $I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 25^\circ\text{C}$ 

Figure 6 Typ. channel reverse characteristics

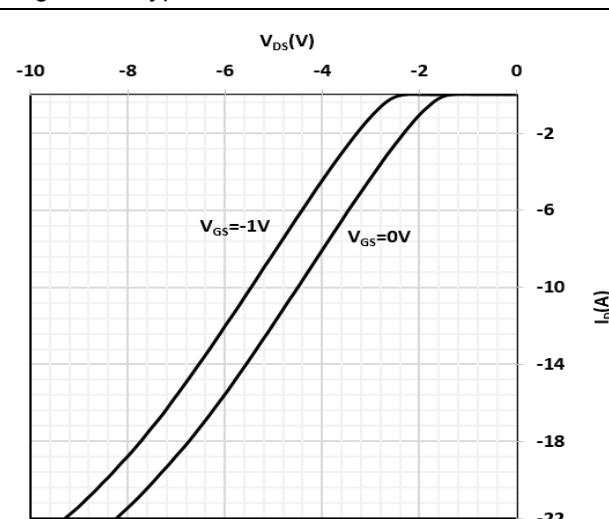
 $I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 125^\circ\text{C}$ 

Figure 7 Typ. channel reverse characteristics

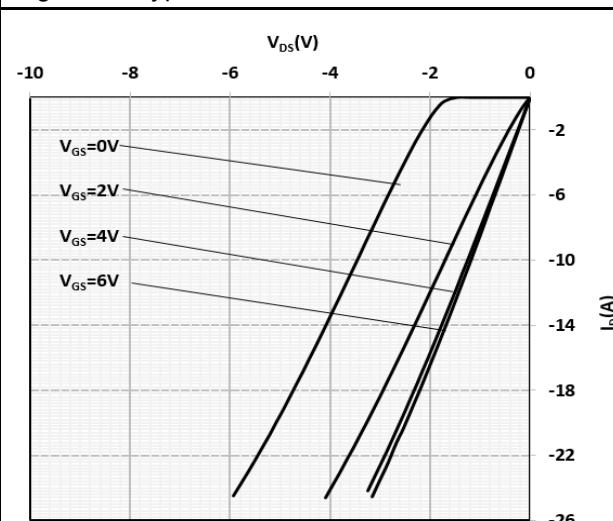
 $I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 25^\circ\text{C}$ 

Figure 8 Typ. channel reverse characteristics

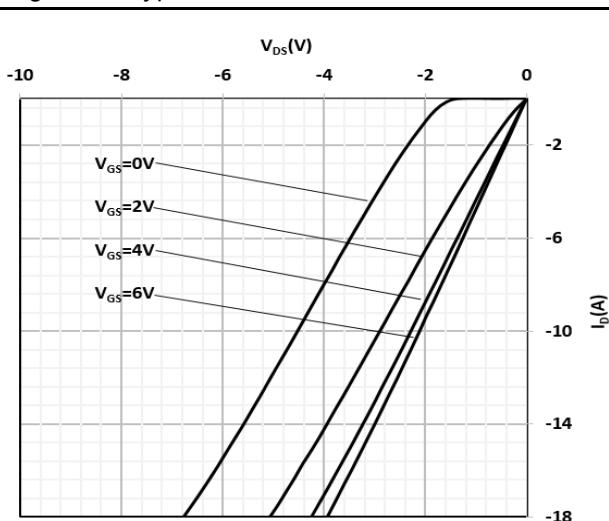
 $I_D = f(V_{DS}, V_{GS})$ ;  $T_j = 125^\circ\text{C}$

Figure 9 Typ. transfer characteristics

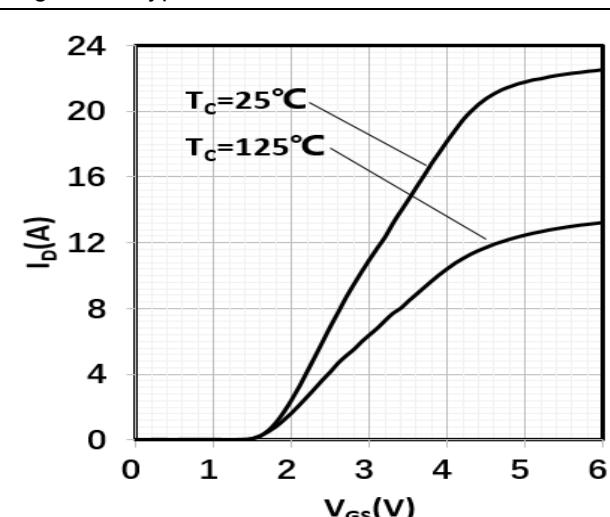
 $I_D = f(V_{GS})$ ;  $V_{DS} = 3\text{ V}$ 

Figure 10 Typ. Gate-to-Source leakage

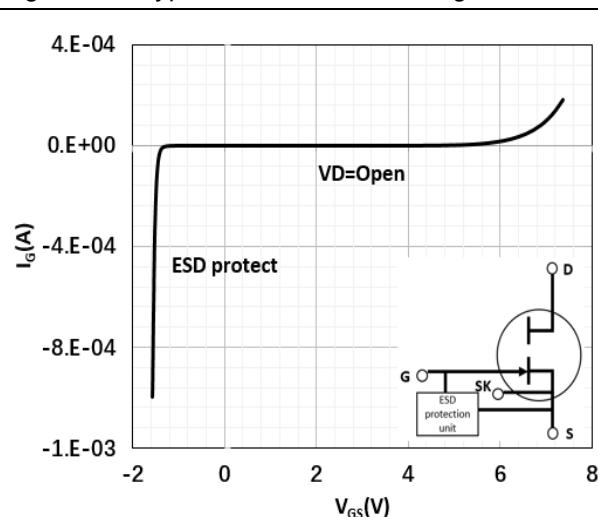
 $I_G = f(V_{GS})$ ;  $I_g$  reverse turn on by ESD unit

Figure 11 Drain-source leakage characteristics

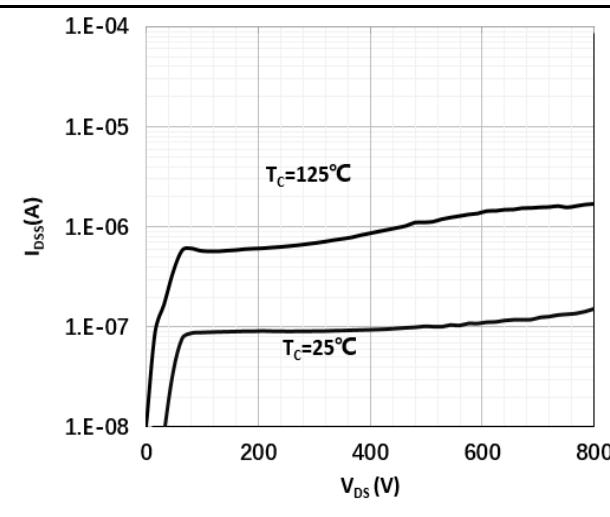
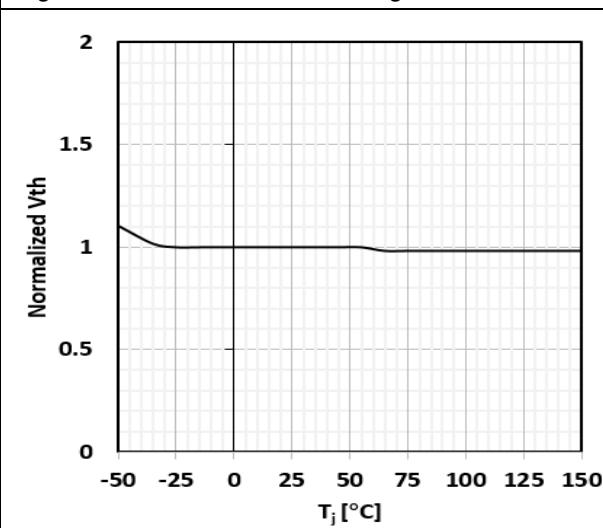
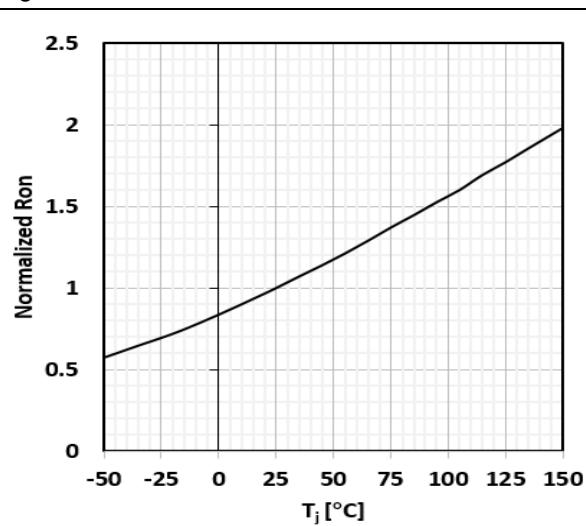
 $I_{DSS} = f(V_{DS})$ ;  $V_{GS} = 0\text{ V}$

Figure 12 Gate threshold voltage



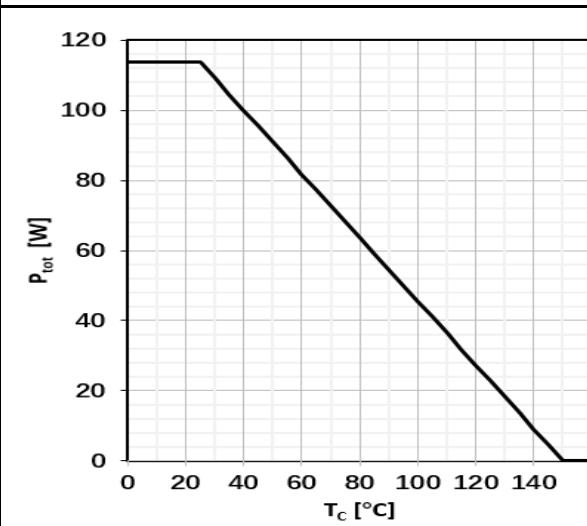
$$V_{TH} = f(T_j); \quad V_{GS} = V_{DS}; \quad I_D = 17.2 \text{ mA}$$

Figure 13 Drain-source on-state resistance



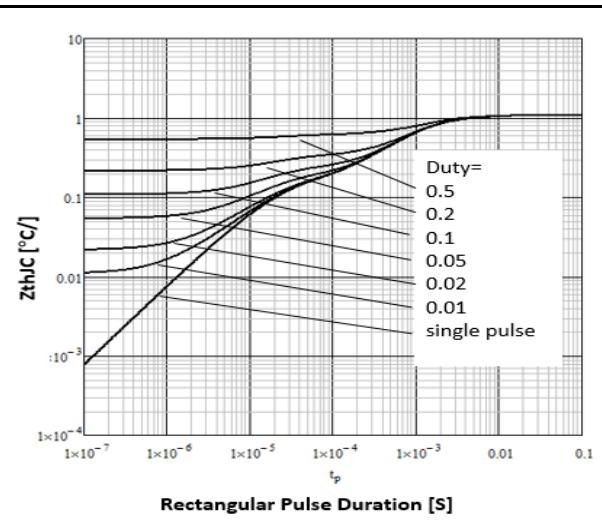
$$R_{DS(on)} = f(T_j); \quad I_D = 5 \text{ A}; \quad V_G = 6 \text{ V}$$

Figure 14 Power dissipation



$$P_{tot} = f(T_c)$$

Figure 15 Max.transient thermal impedance



$$Z_{thJC} = f(t_p, D)$$

Figure 16 Safe operating area

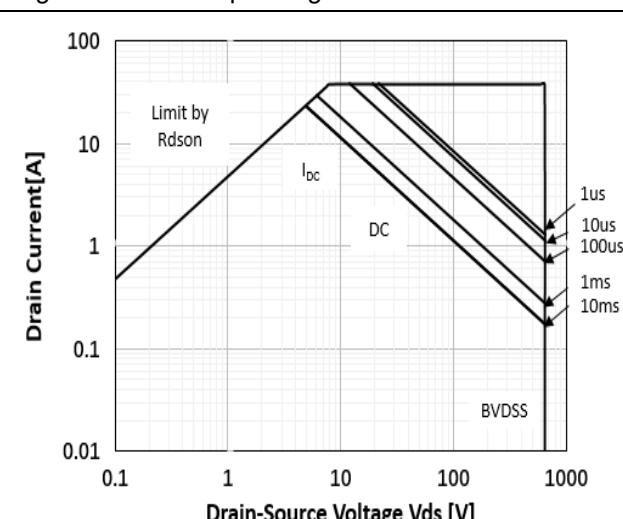
 $I_D = f(V_{DS})$ ;  $T_C = 25^\circ C$ 

Figure 17 Safe operating area

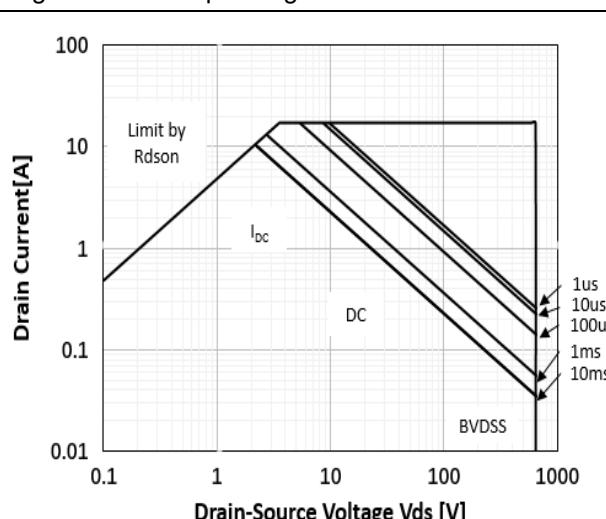
 $I_D = f(V_{DS})$ ;  $T_C = 125^\circ C$ 

Figure 18 Typ. gate charge

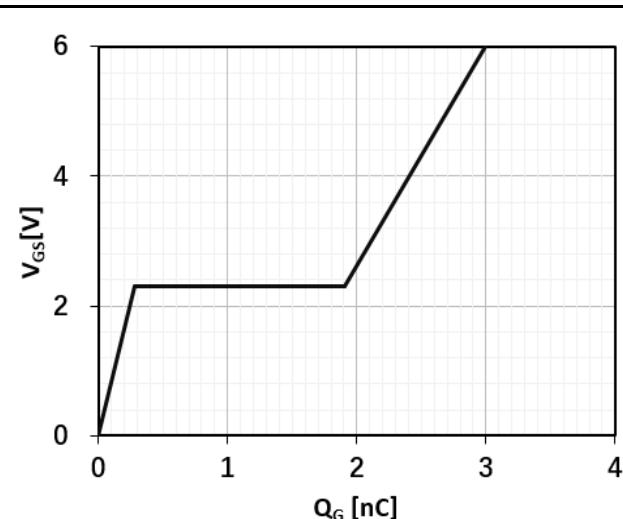
 $V_{GS} = f(Q_G)$ ;  $V_{DCLINK} = 400 V$ ;  $I_D = 5 A$ 

Figure 19 Typ. capacitances

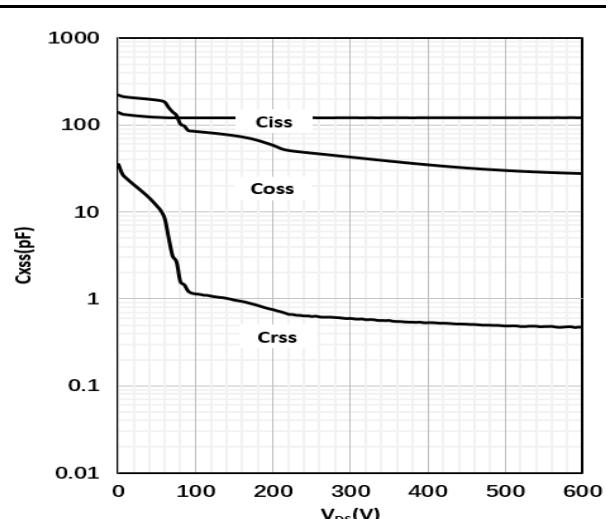
 $C_{xss} = f(V_{DS})$ ; Freq. = 100 kHz

Figure 20 Typ. output charge

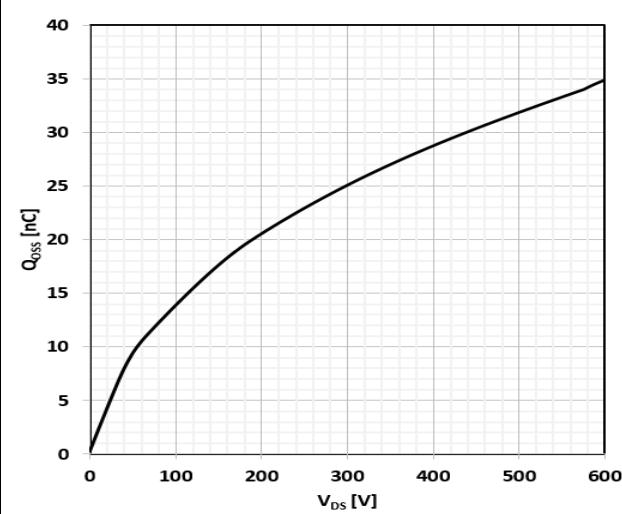
 $Q_{oss} = f(V_{DS})$ ; Freq. = 100 kHz

Figure 21 Typ. Coss stored Energy

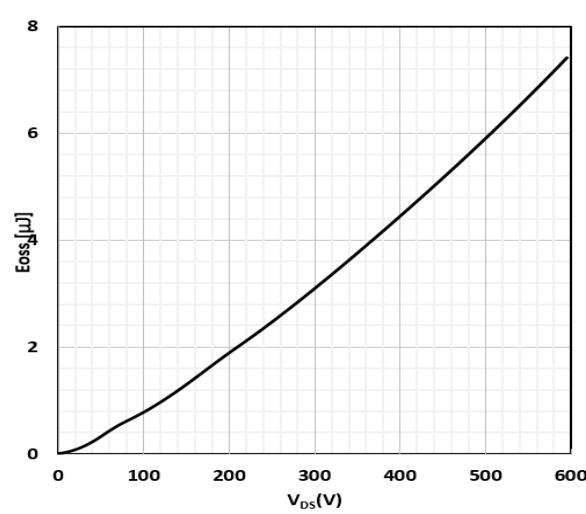
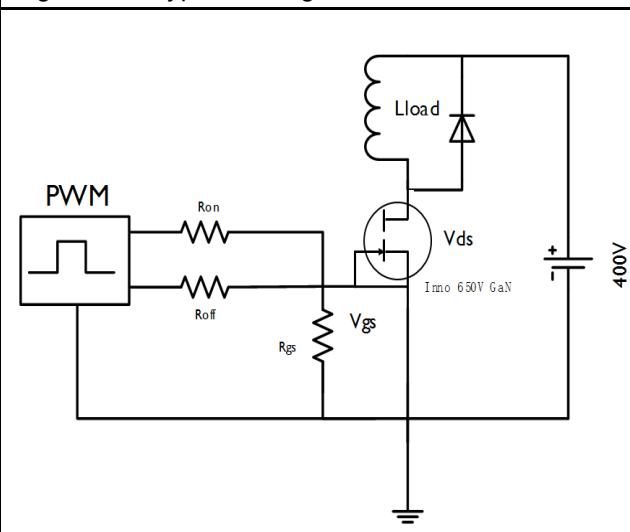
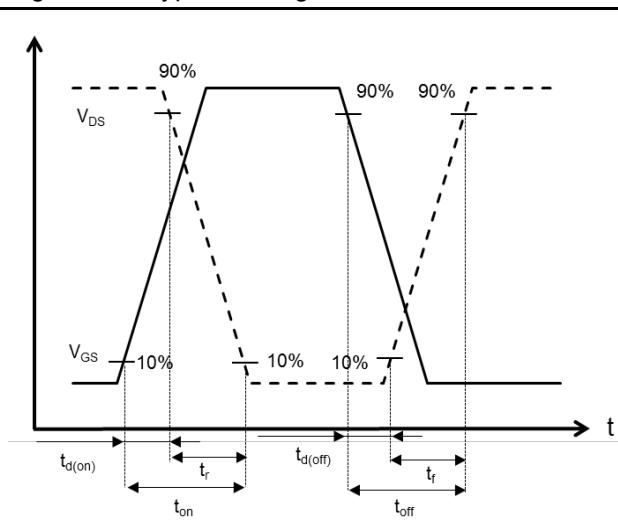
 $E_{oss} = f(V_{DS})$ ; Freq. = 100 kHz

Figure 22 Typ.Switching times with inductive load

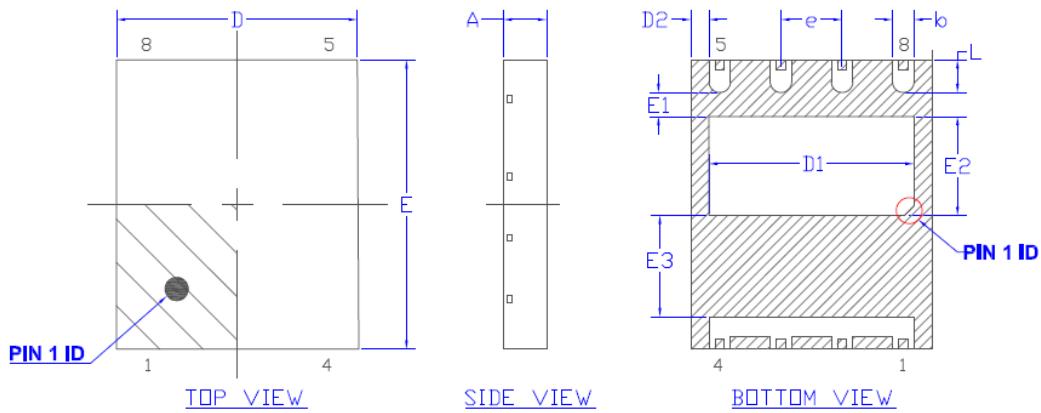


$V_{DS}=400V$ ,  $I_D=5A$ ,  $L_{load}=800\mu H$ ,  $V_{GS}=6V$ ,  $R_{on}=10\Omega$ ,  
 $R_{off}=2\Omega$ ,  $R_{gs}=10k\Omega$

Figure 23 Typ.Switching times waveform



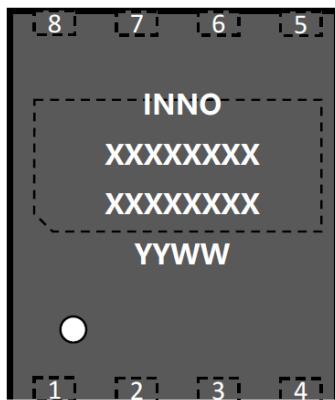
## 10. Package outlines



SYMBOL	DIMENSION			SYMBOL	DIMENSION		
	MIN	NOM	MAX		MIN	NOM	MAX
A	0.80	0.90	1.00	E	6.00 B.S.C		
A1	0.00	0.02	0.05	E1	0.40	0.50	0.60
A2	---	0.203 ref	---	E2	1.95	2.05	2.15
b	0.40	0.45	0.50	E3	---	2.10	---
D	5.00 B.S.C			e	1.27 B.S.C		
D1	4.16	4.26	4.36	L	0.575	0.675	0.775
D2	0.27	0.37	0.47				

### Notes:

- (1) Dimension and tolerance conform to ASME Y14.5-2009.
- (2) All dimensions are in millimeters.
- (3) Lead coplanarity shall be 0.1 millimeters max.
- (4) Complies with JEDEC MO-229.
- (5) Drawing is not to scale.



Row	Description	Example
Row 1	Company name	INNO
Row 2	Product code (In short)	XXXXXXXXXX
Row 3	ASSY lot No.	XXXXXXXXXX
Row 4	Date code	YYWW

## 11. Revision history

### Major changes since the last revision

Revision	Date	Description of changes
1.0	2021-4-26	1.0 version release

## Important Notice

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